Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/777,465	LINN ET AL.		
Examiner	Art Unit		
Hwei-Siu C. Payer	3724		

SEARCHED							
Class	Subclass	Date	Examiner				
030	158	10-13-05	Payer				
	159						
	160						
	161						

INI	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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